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| Notice of References Cited | Application/Control No. 10/748,385 | Applicant(s)/Patent Under Reexamination WEI, WEN | |
| | Examiner Hung S. Bui | Art Unit 2841 | Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|-------------------|----------------|
| | A | US-2005/0071689 | 03-2005 | Coward et al. | 713/300 |
| | B | US-6,499,609 | 12-2002 | Patriche et al. | 211/175 |
| | C | US-2003/0235042 | 12-2003 | Harris et al. | 361/752 |
| | D | US-6,222,729 | 04-2001 | Yoshikawa, Minoru | 361/695 |
| | E | US-6,483,700 | 11-2002 | Malone et al. | 361/690 |
| | F | US-6,278,608 | 08-2001 | Ater et al. | 361/695 |
| | G | US- | | | |
| | H | US- | | | |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
| | W | |
| | X | |

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